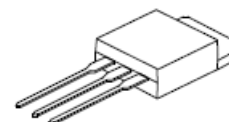


500V/11A Power MOSFET (N-Channel)

General Description

- MSU11N50Q is a N-Channel enhancement mode power MOSFET with advanced technology. It is designed to have Better characteristics, such as fast switching time, low gate charge, minimized on-state resistance and withstanding high energy pulse in the avalanche and commutation modes. These devices are well suited for high efficiency switching mode power supply applications.



TO-262

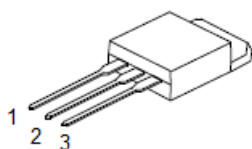


HALOGEN
FREE

Features

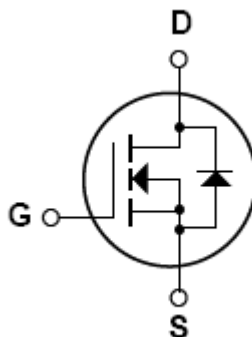
- $R_{DS(ON)} = 0.55\Omega @ V_{GS} = 10V$
- Fast switching capability
- Avalanche energy tested
- Improved dv/dt capability, high ruggedness
- RoHS Compliance and Halogen free

Pin Configuration and Symbol



1: GATE 2: DRAIN 3: SOURCE

TO-262



500V/11A POWER MOSFET (N-Channel)

MSU11N50Q

Absolute Maximum Ratings ($T_C=25^{\circ}\text{C}$ unless otherwise specified, Note)

| Symbol | Description | Ratings | Unit | |
|------------------------|--|-------------------------------|------|------|
| V_{DSS} | Drain-Source Voltage | 500 | V | |
| V_{GSS} | Gate-Source Voltage | ± 30 | V | |
| I_D | Drain Current -Continuous | T _C =25°C (Note1) | 11 | A |
| | | T _C =100°C (Note1) | 7 | A |
| I_{DM} | Drain Current -Pulsed (note2) | 44 | A | |
| E_{AS} | Single Pulsed Avalanche Energy (Note 3) | 670 | mJ | |
| dv/dt | Peak Diode Recovery dv/dt (Note4) | 4.5 | V/ns | |
| P_D | Power Dissipation | T _C =25°C | 195 | W |
| | | Derate above 25°C | 1.56 | W/°C |
| R_{θJA} | Thermal Resistance (Junction-to-Ambient) | 62.5 | °C/W | |
| R_{θJC} | Thermal Resistance (Junction-to-Case) | 0.64 | °C/W | |
| T_J | Junction Temperature | +150 | °C | |
| T_{STG} | Storage Temperature Range | -55 to +150 | °C | |

Note: Absolute maximum ratings indicate limits beyond which damage to the device may occur.
For guarantee specification and test conditions, see the Electrical Characteristics.
The guaranteed specification apply only for the test conditions listed.

- Note1: Drain current limited by maximum junction temperature
2: Repetitive Rating: Pulse width limited by maximum junction temperature
3: L=10mH, I_{AS}=11A, V_{DD}=50V, R_G=25Ω, Starting T_J=25°C
4: I_{sd}≤11A, di/dt≤200A/μs, V_{DD}≤V_{BR(DSS)}, Starting T_J=25°C

500V/11A POWER MOSFET (N-Channel)

MSU11N50Q

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise specified)

| Symbol | Description | Min. | Typ. | Max. | Unit | Conditions | |
|---|---|---------|------|------|----------|---|--------------------------|
| OFF CHARACTERISTICS | | | | | | | |
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage | 500 | - | - | V | $V_{GS}=0V, I_D=250\mu A$ | |
| $\Delta V_{(BR)DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | - | 0.5 | - | V/°C | $I_D=250\mu A$ | |
| I_{DSS} | Drain-Source leakage Current | - | - | 10 | μA | $V_{DS}=500V, V_{GS}=0V$ | |
| | | - | - | 100 | μA | $V_{DS}=500V, T_J=125^\circ C$ | |
| I_{GSS} | Gate-Source leakage Current | Forward | - | - | 100 | nA | $V_{GS}=30V, V_{DS}=0V$ |
| | | Reverse | - | - | -100 | nA | $V_{GS}=-30V, V_{DS}=0V$ |
| ON CHARACTERISTICS | | | | | | | |
| $V_{GS(th)}$ | Gate-Source Threshold Voltage | 2.0 | - | 4.0 | V | $V_{DS}=V_{GS}, I_D=250\mu A$ | |
| $R_{DS(on)}$ | Static Drain-Source On-State Resistance | - | 0.48 | 0.55 | Ω | $V_{GS}=10V, I_D=5.5A$ | |
| DYNAMIC CHARACTERISTICS | | | | | | | |
| C_{iss} | Input Capacitance | - | 1515 | 2055 | pF | $V_{DS}=25V, V_{GS}=0V, f=1.0MHz$ | |
| C_{oss} | Output Capacitance | - | 185 | 235 | pF | | |
| C_{rss} | Reverse Transfer Capacitance | - | 25 | 30 | pF | | |
| SWITCHING CHARACTERISTICS | | | | | | | |
| $t_d(on)$ | Turn-on Delay Time | - | 24 | 57 | nS | $V_{DD}=250V, I_D=11A, R_G=3\Omega$ (Note 5,6) | |
| t_r | Turn-on Rise Time | - | 70 | 150 | nS | | |
| $t_d(off)$ | Turn-off Delay Time | - | 120 | 250 | nS | | |
| t_f | Turn-off Fall Time | - | 75 | 160 | nS | | |
| Q_g | Total Gate Charge | - | 43 | 55 | nC | $V_{DS}=400V, I_D=11A, V_{GS}=10V$ (Note 5,6) | |
| Q_{gs} | Gate-Source Charge | - | 8 | - | nC | | |
| Q_{gd} | Gate-Drain Charge | - | 19 | - | nC | | |
| DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS | | | | | | | |
| V_{SD} | Drain-Source Diode Forward Voltage | - | - | 1.4 | V | $V_{GS}=0V, I_S=11A$ | |
| I_S | Maximum Continuous Drain-Source Diode Forward Current | - | - | 11 | A | - | |
| I_{SM} | Maximum Pulse Drain-Source Diode Forward Current | - | - | 44 | A | - | |
| t_{rr} | Reverse Recovery Time | - | 90 | - | nS | $V_{GS}=0V, I_S=11A$ | |
| Q_{rr} | Reverse Recovery Charge | - | 1.5 | - | μC | $dI_F/dt=100A/\mu s$ (Note5) | |

Note 5: Pulse test: Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$

6: Essentially independent of operating temperature

TEST CIRCUIT AND WAVEFORMS

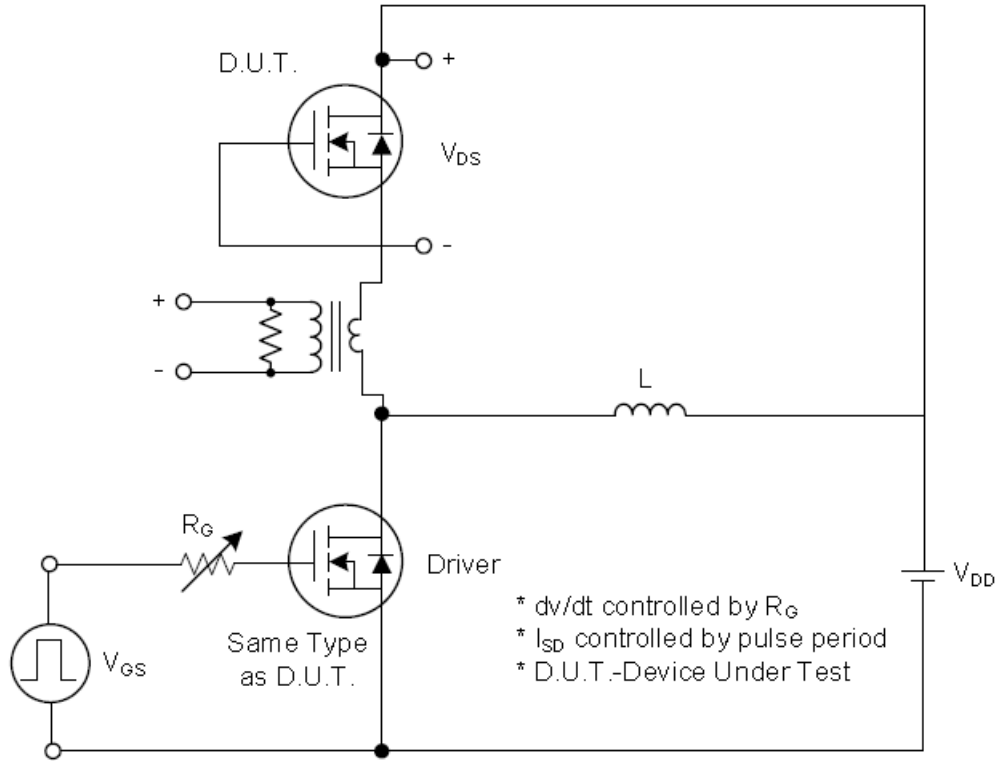


Fig.1- Peak Diode Recovery dv/dt Test Circuit

500V/11A POWER MOSFET (N-Channel)

MSU11N50Q

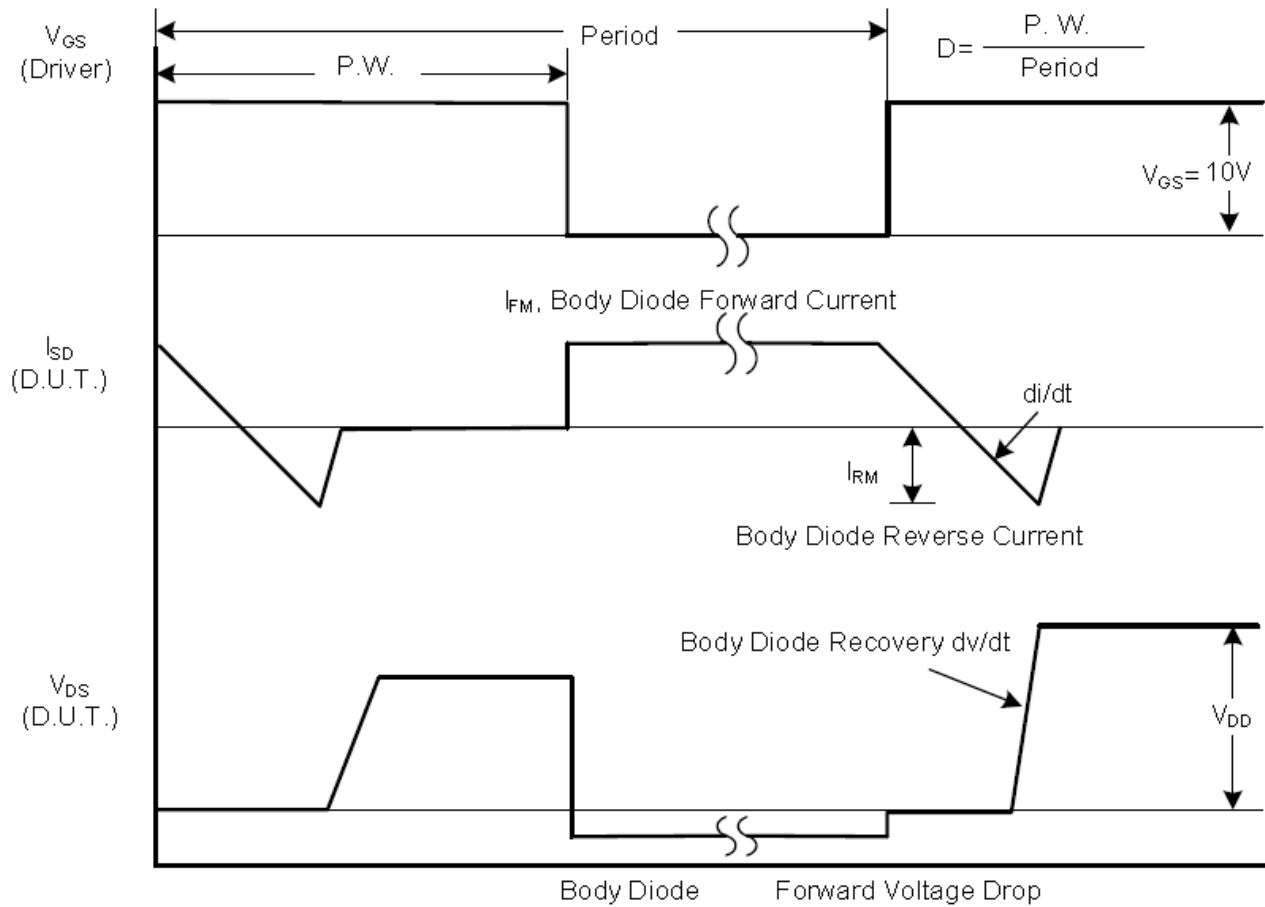


Fig.2- Peak diode Recovery dv/dt Waveform

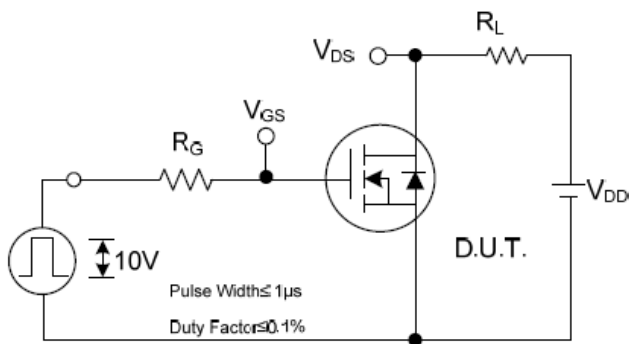


Fig.3- Switching Test Circuit

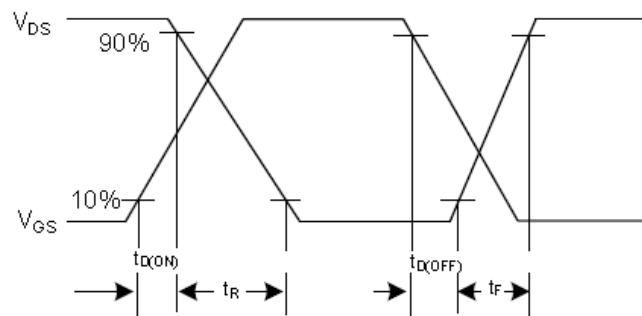


Fig.4- Switching Waveform

500V/11A POWER MOSFET (N-Channel)

MSU11N50Q

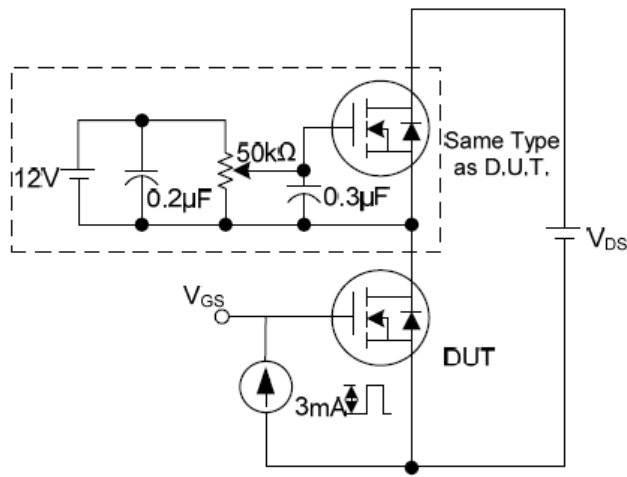


Fig.5- Gate Charge Test Circuit

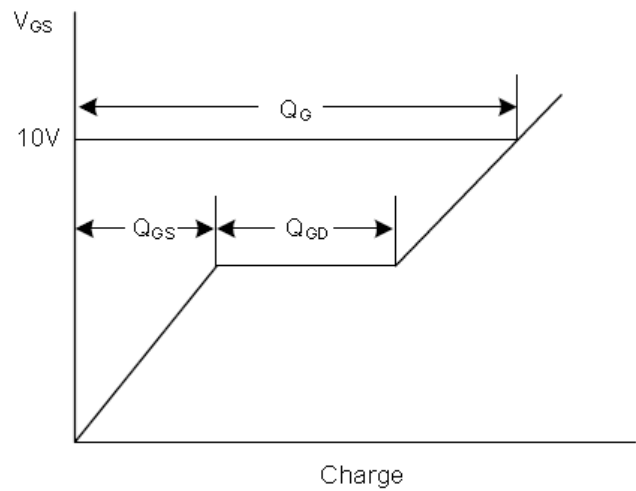


Fig.6- Gate Charge Waveform

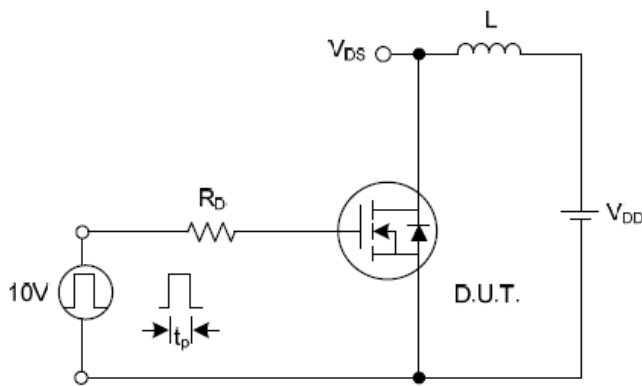


Fig.7- Unclamped Inductive Switching Test Circuit

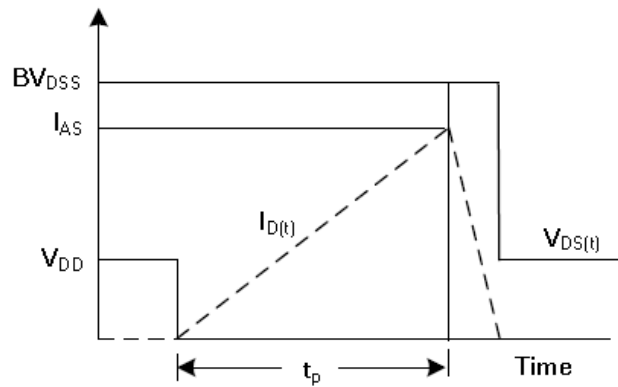


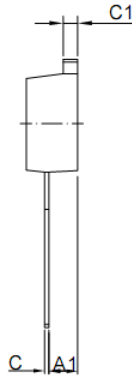
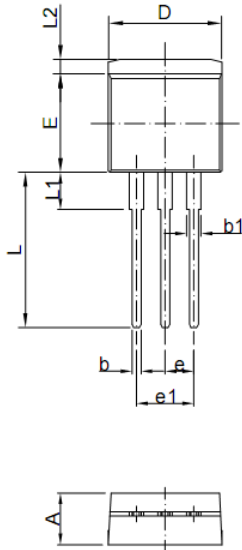
Fig.8 Unclamped Inductive Switching Waveform

500V/11A POWER MOSFET (N-Channel)

MSU11N50Q

Dimensions in mm (inch)

TO-262

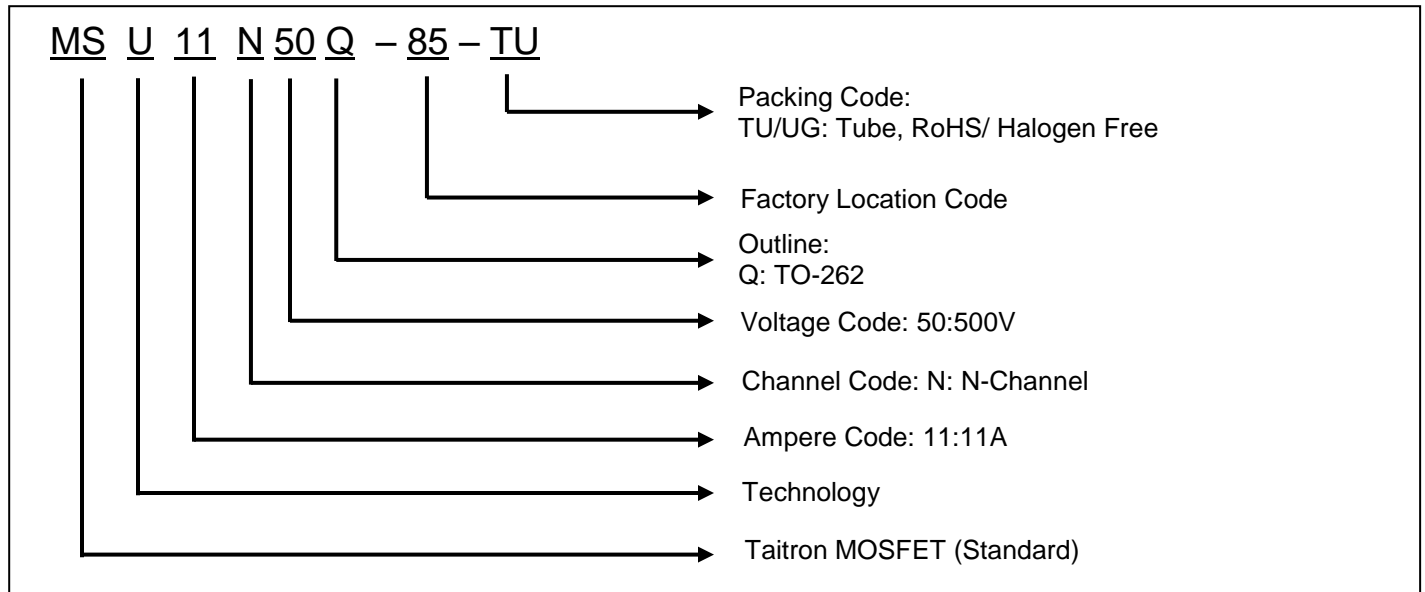


| Symbol | Dimensions in Millimeters | | Dimensions in Inches | |
|--------|---------------------------|-------|----------------------|-------|
| | Min | Max | Min | Max |
| A | 4.06 | 4.83 | 0.160 | 0.190 |
| A1 | 2.040 | 2.95 | 0.080 | 0.116 |
| b | 0.50 | 1.00 | 0.020 | 0.039 |
| b1 | 1.14 | 1.78 | 0.045 | 0.070 |
| C | 0.33 | 0.74 | 0.013 | 0.029 |
| C1 | 1.14 | 1.65 | 0.045 | 0.065 |
| D | 9.65 | 10.67 | 0.380 | 0.420 |
| E | 8.38 | 9.65 | 0.330 | 0.380 |
| e | 254 TYP | | 0.100 TYP | |
| L | 12.90 | 13.98 | 0.508 | 0.550 |
| L1 | 3.10 | 3.85 | 0.122 | 0.152 |
| L2 | 1.17 | 1.68 | 0.046 | 0.066 |

500V/11A POWER MOSFET (N-Channel)

MSU11N50Q

Ordering Information



How to contact us

US HEADQUARTERS

28040 WEST HARRISON PARKWAY, VALENCIA, CA 91355-4162

Tel: (800)-TAITRON (800)-824-8766 (661)-257-6060

Fax: (800)-TAITFAX (800)-824-8329 (661)-257-6415

Email: taitron@taitroncomponents.com

Http://www.taitroncomponents.com

TAITRON COMPONENTS MEXICO, S.A .DE C.V.

BOULEVARD CENTRAL 5000 INTERIOR 5 PARQUE INDUSTRIAL ATITALAQUIA, HIDALGO

C.P. 42970 MEXICO

Tel: +52-55-5560-1519

Fax: +52-55-5560-2190

TAITRON COMPONENTS INCORPORATED TAIWAN, TAIPEI

6F., No.190, Sec. 2, Zhongxing Rd., Xindian Dist., New Taipei City 23146, Taiwan R.O.C.

Tel: 886-2-2913-6238

Fax: 886-2-2913-6239

TAITRON COMPONENT TECHNOLOGY, SHANGHAI CORPORATION

METROBANK PLAZA, 1160 WEST YAN'AN ROAD, SUITE 1503, SHANGHAI, 200052, CHINA

Tel: +86-21-5424-9942

Fax: +86-21-2302-5027